

THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Hirohito OKUDA et al.
Serial No.: 10/809,464
Filed: March 26, 2004
Title: APPARATUS AND METHOD FOR CLASSIFYING DEFECTS
USING MULTIPLE CLASSIFICATION MODULES (as amended)
Group: 2624
Examiner: Edward PARK
Confirmation No.: 7643

AMENDMENT

Mail Stop: AF

Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450

August 24, 2010

Sir:

In response to the Office Action dated February 25, 2010, the period of response for which extension of time is requested in the attached Petition for Extension of Time, and concurrently filed with the attached Request for Continued Examination (RCE), please amend the above-identified application as listed below and as set forth on the following pages:

Amendments to the claims begin on page 2;

Remarks are included beginning on page 6; and

Authorization is included on page 14.